



P-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}$ (Ω) Max.	I _D (A)	Q _g (Typ.)
- 30	0.015 at V _{GS} = - 10 V	- 12 ^a	20 nC
- 30	0.022 at V _{GS} = - 4.5 V	- 12 ^a	20110

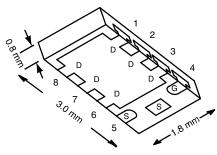
FEATURES

- TrenchFET[®] Power MOSFET
- Thermally Enhanced PowerPAK[®] ChipFET[®] Package
 - Small Footprint Area, Thin 0.8 mm Profile
 - Low On-Resistance
- 100 % R_g Tested
- Material categorization:
 For definitions of compliance please see www.vishay.com/doc?99912

Pb-free

ROHS COMPLIANT HALOGEN FREE

PowerPAK® ChipFET® Single

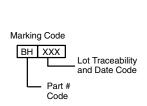


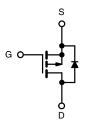
Bottom View

Ordering Information: Si5429DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- Power Management for Mobile Computing
 - Adaptor Switch
 - Load Switch
 - DC/DC Converter





P-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	v	
Gate-Source Voltage		V_{GS}	± 20		
	T _C = 25 °C		- 12 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I.	- 12 ^a		
Continuous Diain Current (1) = 130 °C)	T _A = 25 °C	l _D	- 11.8 ^{b, c}		
	T _A = 70 °C		- 9.4 ^{b, c}	A	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 50		
Continuous Source-Drain Diode Current	T _C = 25 °C	l _a	- 12 ^a		
Continuous Source-Diain Diode Current	T _A = 25 °C	ls —	- 11.86 ^{b, c}		
	T _C = 25 °C		31		
Maximum Power Dissipation	T _C = 70 °C	P _D	20	W	
Maximum Power Dissipation	T _A = 25 °C	l D	3.1 ^{b, c}	VV	
	T _A = 70 °C		2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RA	TINGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	34	40	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3	4	C/VV

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- t = 5
- d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- . Maximum under steady state conditions is 90 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	L						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			- 20		1400	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4.4		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	- 1.0		- 2.2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
· · · · · · · · · · · · · · · · · · ·	0.00	V _{DS} = - 30 V, V _{GS} = 0 V			- 1		
		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -3 \text{ V}, V_{GS} = 0 \text{ V}$		- 0.0001		μΑ	
•		V _{DS} = - 3 V, V _{GS} = 0 V, T _J = 0 °C		- 0.0001		1	
		V _{DS} = - 3 V, V _{GS} = 0 V, T _J = 55 °C		- 0.0001			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
Drain-Source On-State Resistance ^a		V _{GS} = - 10 V, I _D = - 7 A		0.0122	0.015	Ω	
	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 5 A		0.0178	0.022		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 7 A		25		S	
Dynamic ^b	0.0	50 5					
Input Capacitance	C _{iss}			2320			
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		275		pF	
Reverse Transfer Capacitance	C _{rss}			235			
	Qg	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 12 A		42	63		
Total Gate Charge				20	30		
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 12 A		6.3		nC	
Gate-Drain Charge	Q _{ad}			6.3			
Gate Resistance	R _g	f = 1 MHz	0.8	4.2	8.4	Ω	
Turn-on Delay Time	t _{d(on)}			35	70		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		25	50		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_q = 1 \Omega$		31	60		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			10	20	ns	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_q = 1 \Omega$		40	80	1	
Fall Time	t _f	, and a second s		10	20		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 12		
Pulse Diode Forward Current	I _{SM}				50	Α	
Body Diode Voltage	V _{SD}	I _S = - 10 A, V _{GS} = 0 V		- 0.83	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			10	20	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 40 A 41/44 400 A/ T 05 00		3	10	nC	
Reverse Recovery Fall Time	t _a	$I_F = -10 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		6			
Reverse Recovery Rise Time	t _b			4		ns	

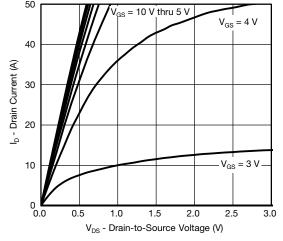
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- a. Guaranteed by design, not subject to production testing.

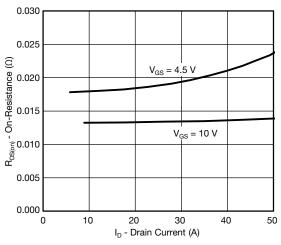
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



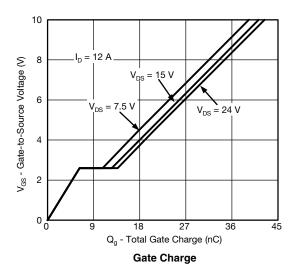
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

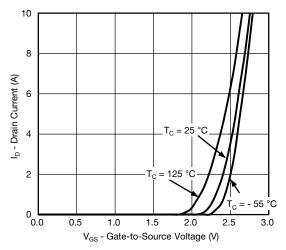


Output Characteristics

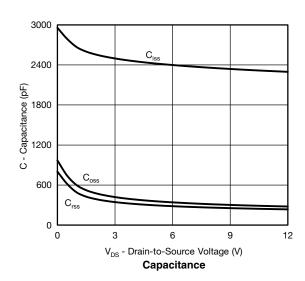


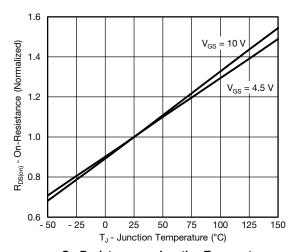
On-Resistance vs. Drain Current





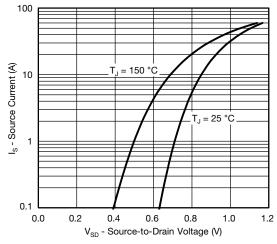
Transfer Characteristics



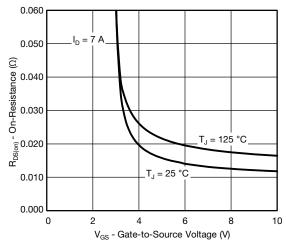


On-Resistance vs. Junction Temperature

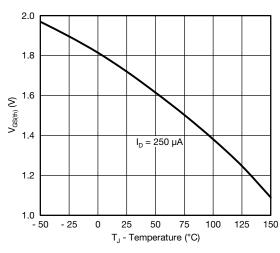
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



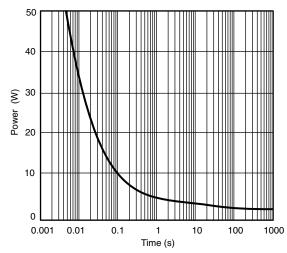
Source-Drain Diode Forward Voltage



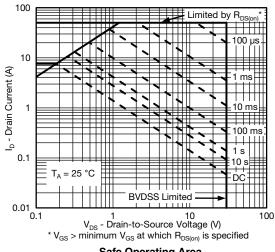
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power

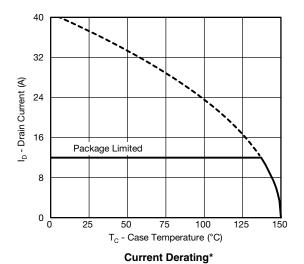


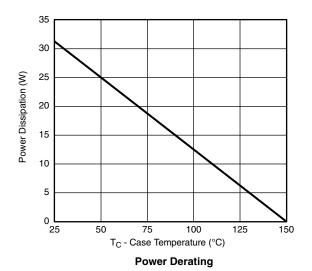






TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

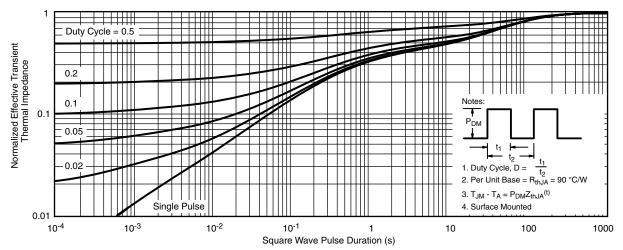




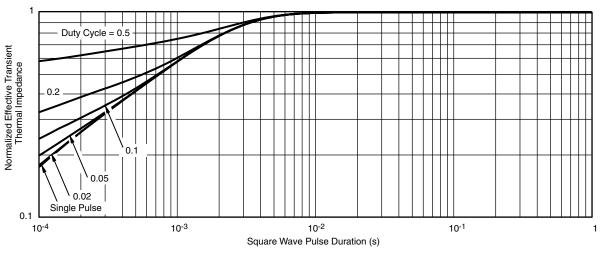
^{*} The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

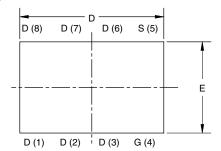


Normalized Thermal Transient Impedance, Junction-to-Case

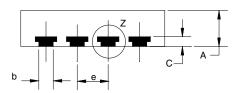
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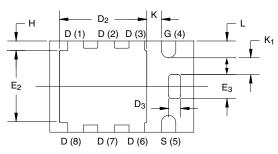


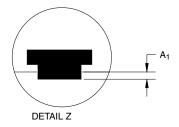
PowerPAK® ChipFET® SINGLE PAD











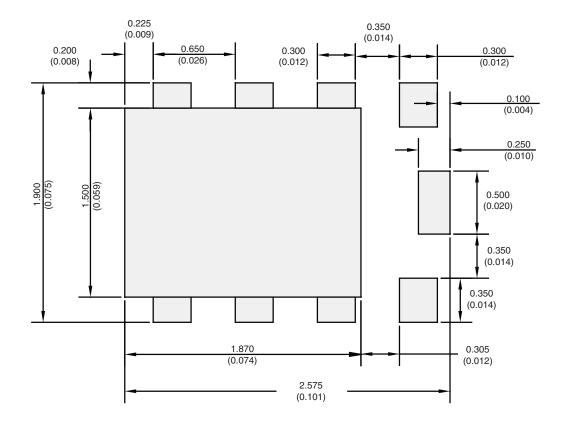
Backside view of single pad

	MILLIMETERS			INCHES			
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A ₁	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D ₂	1.75	1.87	2.00	0.069	0.074	0.079	
D ₃	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E ₂	1.38	1.50	1.63	0.054	0.059	0.064	
E ₃	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC			0.026 BSC		
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	-	
K ₁	0.30	-	-	0.012	-	-	
L	0.30	0.35	0.40	0.012	0.014	0.016	

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RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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Revision: 02-Oct-12 Document Number: 91000

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